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ATTY DOCKET NO. SERIAL NO. Form PTO 1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE (Modified) 209284US99 09/842,734 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Zhiyi YU, et al. **FILING DATE GROUP** 2811 April 26, 2001 **U.S. PATENT DOCUMENTS DOCUMENT** SUB **FILING DATE EXAMINER CLASS** DATE NAME **CLASS** IF APPROPRIATE INITIAL NUMBER W VW 2002/0079576 06/27/02 Seshan VX 5,148,504 09/15/92 Levi et al. VY 12/26/02 Klosowiak 2002/0195610 A1 12/19/95 VΖ Matsuda 5,477,363 WA 5,905,571 05/18/99 Butler et al. 10/29/96 WB 5,570,226 02/11/92 Ishibashi et al. WC 5,087,829 09/06/01 WD 2001/0020278 A1 Saito WE 6,496,469 B1 12/17/02 Uchizaki WF 5,679,947 10/21/97 Doi et al. 2001/0036142 A1 11/01/01 Kadowaki et al. WG Yoshida et al. WH 5,446,719 08/29/95 11/03/98 Jiang et al. WI 5,831,960 WJ 5.693,140 12/02/97 McKee et al. WK 04/23/02 Wang et al. 6,376,337 B1 WL 4,177,094 12/04/79 Kroon 5,216,359 06/01/93 Makki et al. WM Nashimoto et al. WN 6,307,996 B1 10/23/01 WO 5,371,621 12/06/94 Stevens WP 2002/0145168 A1 10/10/02 Bojarczuk, Jr et al. WQ 3,617,951 11/02/71 Anderson WR 5,838,053 11/17/98 Bevan et al. Ш ws 5,684,302 11/04/97 Wersing et al. WT 5,959,308 09/28/99 Shichijo et al. WU 11/08/94 5,362,972 Yazawa et al. wv 01/26/99 Yamamoto et al. 5,864,171 ww 5,028,563 07/02/91 Feit et al. wx 08/10/99 Domash 5,937,115 **Date Considered** Examiner

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